


**FCC PART 15 CLASS B**  
**EMI MEASUREMENT AND TEST REPORT**  
**FOR**

**MICROTEK LABS. INC.**

3715 Doolittle Drive  
Redondo, CA 90278

**FCC ID: EF9MRS-1200LC**

March 16, 1999

<b>This Report Concerns:</b> <input checked="checked" type="checkbox"/> Original Report	<b>Equipment Type:</b> Scanner - Subassembly, ITE
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<b>Test Date:</b> March 16, 1999	
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**TABLE OF CONTENTS**

<b>1 - GENERAL INFORMATION .....</b>	<b>4</b>
1.1 PRODUCT DESCRIPTION FOR EQUIPMENT UNDER TEST (EUT) .....	4
1.2 OBJECTIVE.....	4
1.3 TEST METHODOLOGY.....	4
1.4 TEST FACILITY.....	4
1.5 TEST EQUIPMENT LIST AND DETAILS .....	5
1.6 EQUIPMENT UNDER TEST (EUT) .....	5
1.7 HOST SYSTEM CONFIGURATION LIST AND DETAILS.....	6
1.9 EXTERNAL I/O CABLING LIST AND DETAILS .....	6
<b>2 - SYSTEM TEST CONFIGURATION.....</b>	<b>7</b>
2.1 JUSTIFICATION.....	7
2.2 EUT EXERCISE SOFTWARE.....	7
2.3 SPECIAL ACCESSORIES .....	7
2.4 SCHEMATICS / BLOCK DIAGRAM .....	7
2.5 CONFIGURATION OF TEST SYSTEM.....	8
2.6 TEST SETUP BLOCK DIAGRAM.....	9
2.7 EQUIPMENT MODIFICATIONS .....	10
<b>3 - CONDUCTED EMISSIONS TEST DATA .....</b>	<b>11</b>
3.1 MEASUREMENT UNCERTAINTY.....	11
3.2 EUT SETUP .....	11
3.3 SPECTRUM ANALYZER SETUP.....	11
3.4 TEST PROCEDURE .....	12
3.5 SUMMARY OF TEST RESULTS.....	12
3.6 CONDUCTED EMISSIONS TEST DATA.....	12
3.7 PLOT OF CONDUCTED EMISSIONS TEST DATA .....	12
<b>4 - RADIATED EMISSION DATA .....</b>	<b>13</b>
4.1 MEASUREMENT UNCERTAINTY.....	13
4.2 EUT SETUP .....	13
4.3 SPECTRUM ANALYZER SETUP.....	13
4.4 TEST PROCEDURE .....	14
4.5 CORRECTED AMPLITUDE & MARGIN CALCULATION.....	14
4.6 SUMMARY OF TEST RESULTS.....	14
4.7 RADIATED EMISSIONS TEST DATA.....	15
<b>5- FCC PRODUCT LABELING AND WARNING STATEMENT.....</b>	<b>16</b>
5.1 FCC ID LABEL .....	16
5.2 PROPOSED LABEL LOCATION ON EUT .....	16
5.3 FCC WARNING STATEMENT.....	16
<b>6 - CONDUCTED AND RADIATED SETUP PHOTOGRAPHS.....</b>	<b>17</b>
6.1 CONDUCTED EMISSION PHOTOGRAPH – FRONT VIEW .....	17
6.2 CONDUCTED EMISSION PHOTOGRAPH – SIDE VIEW .....	18
6.3 RADIATED EMISSION PHOTOGRAPH – FRONT VIEW .....	19
6.4 RADIATED EMISSION PHOTOGRAPH – REAR VIEW.....	20
<b>7 – PHOTOGRAPHS.....</b>	<b>21</b>
7.1 EUT: FRONT VIEW .....	21
7.2 EUT: REAR VIEW .....	22
7.3 EUT: COVER OPEN WITH COVER ON VIEW.....	23
7.4 EUT: INSIDE COVER VIEW.....	24
7.5 EUT: COVER VIEW .....	25
7.6 EUT: WITHOUT COVER OF CIRCUIT BOARD VIEW .....	26
7.7 EUT: INSIDE MAIN BOARD COMPONENT VIEW .....	27
7.8 EUT: INSIDE MAIN BOARD CIRCUIT VIEW.....	28

7.9 EUT: POWER SUPPLY CIRCUIT BOARD COMPONENT VIEW ..... 29

7.10 EUT: POWER SUPPLY CIRCUIT BOARD CIRCUIT VIEW..... 30

7.11 EUT: SWITCH BOARD COMPONENT VIEW..... 31

7.12 EUT: SWITCH BOARD CIRCUIT VIEW..... 32

7.13 EUT: SCANNERHEAD ASSEMBLE VIEW..... 33

7.14 EUT: SCANNER BOARD COMPONENT VIEW ..... 34

7.15 EUT: SCANNER BOARD CIRCUIT VIEW ..... 35

7.16 EUT: SCANNER HEAD FRONT VIEW ..... 36

7.17 EUT: SCANNER HEAD REAR VIEW ..... 37

7.18 EUT: SCANNER HEAD BOTTOM VIEW..... 38

7.19 EUT: SCANNER HEAD TOP WITHOUT COVER VIEW ..... 39

7.20 EUT: SCANNER LAMP CIRCUIT BOARD COMPONENT VIEW ..... 40

7.21 EUT: SCANNER LAMP CIRCUIT BOARD CIRCUIT VIEW ..... 41

**APPENDIX A – EUT SCHEMATICS / BLOCK DIAGRAM ..... 42**

**APPENDIX B – PLOT(S) OF CONDUCTED EMISSION TEST DATA ..... 43**

**APPENDIX C – USER MANUAL..... 44**

## 1 - GENERAL INFORMATION

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### 1.1 Product Description for Equipment Under Test (EUT)

The MICROTEK LAB. INC.'s MRS-1200LC or the "EUT" as referred to in this report is a 36-bit, legal-size high-resolution scanner.

The EUT has a four-layered printed circuit board and a two-layered printed Power Supply circuit boards.

The EUT measures approximately 21.5"L x 12.0"W x 3.5"H.

### 1.2 Objective

The following Class B report is prepared on behalf of MICROTEK LAB. INC. in accordance with Part 2, Subpart J, and Part 15, Subparts A and B of the Federal Communication Commissions rules and regulations and to ICES-003 of the Canadian Interference-Causing Equipment Regulations.

The objective of the manufacturer is to demonstrate compliance with FCC Part 15 Class B limits and to ICES-003 requirements for Information Technology Equipment.

### 1.3 Test Methodology

All measurements contained in this report were conducted with ANSI C63.4 –1992, American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the range of 9 kHz to 40 GHz. All radiated and conducted emissions measurement was performed at Bay Area Compliance Laboratory, Corp. The radiated testing was performed at an antenna-to-EUT distance of 3 meters.

### 1.4 Test Facility

The Open Area Test site used by Bay Area Compliance Laboratory Corporation to collect radiated and conducted emission measurement data is located in the back parking lot of the building at 230 Commercial Street, Suite 2, Sunnyvale, California, USA.

Test sites at Bay Area Compliance Laboratory Corporation has been fully described in reports submitted to the Federal Communication Commission (FCC) and Voluntary Control Council for Interference (VCCI). The details of these reports has been found to be in compliance with the requirements of Section 2.948 of the FCC Rules on February 11 and December 10, 1997 and Article 8 of the VCCI regulations on December 25, 1997. The facility also complies with the radiated and AC line conducted test site criteria set forth in ANSI C63.4-1992.

The Federal Communications Commission and Voluntary Control Council for Interference has the reports on file and is listed under FCC file 31040/SIT 1300F2 and VCCI Registration No.: C-674 and R-657. The test sites has been approved by the FCC and VCCI for public use and is listed in the FCC Public Access Link (PAL) database.

Additionally, Bay Area Compliance Laboratory Corporation is a National Institute of Standards and Technology (NIST) accredited laboratory, under the National Voluntary Laboratory Accredited Program (NVLAP). The scope of the accreditation covers the FCC Method - 47 CFR Part 15 - Digital Devices, IEC/CISPR 22: 1993, and AS/NZS 3548: Electromagnetic Interference - Limits and Methods of

Measurement of Information Technology Equipment test methods under NVLAP Lab Code 200167.

### 1.5 Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Cal. Due Data
HP	Spectrum Analyzer	8568B	2610A02165	12/6/99
HP	Spectrum Analyzer	8593B	2919A00242	12/20/99
HP	Amplifier	8349B	2644A02662	12/20/99
HP	Quasi-Peak Adapter	85650A	917059	12/6/99
HP	Amplifier	8447E	1937A01046	12/6/99
A.H. System	Horn Antenna	SAS0200/571	261	12/27/99
Com-Power	Log Periodic Antenna	AL-100	16005	11/2/99
Com-Power	Biconical Antenna	AB-100	14012	11/2/99
Solar Electronics	LISN	8012-50-R-24-BNC	968447	12/28/99
Com-Power	LISN	LI-200	12208	12/20/99
Com-Power	LISN	LI-200	12005	12/20/99
BACL	Data Entry Software	DES1	0001	12/20/99

### 1.6 Equipment Under Test (EUT)

Manufacturer	Description	Model	Serial Number	FCC ID
MICROTEK LAB. INC.	Scanner	MRS-1200LC	985A201341	EF9MRS-1200LC

**1.7 Host System Configuration List and Details**

<b>Manufacturer</b>	<b>Description</b>	<b>Model</b>	<b>Serial Number</b>	<b>FCC ID</b>
INTEL	Motherboard	AL440LX	IMAL74633825	DOC
TEAC	Floppy Drive	FD-235HF	0222873	None
TURBO-COOL	Power Supply	300ATX	7780565410	DOC
Jaton	Video Card	VCS38261 PCI	None	DOC
Western Digital	Hard Drive	Caviar 34300	None	None
Adaptec	SCSI Card	AVA-1505A	BE0A827010P	DOC

**1.8 Local Support Equipment List and Details**

<b>Manufacturer</b>	<b>Description</b>	<b>Model</b>	<b>Serial Number</b>	<b>FCC ID</b>
Quantum3D	PC System	Desktop	None	DOC
Mitsumi	Keyboard	KFK-EA4XA	None	CMYKFK7741
Microsoft	Mouse	KMP5	None	C3KKMP5
Viewsonic	Monitor	P815-1M	None	GSS21002
Microtek	Automatic Document Feeder (ADF)	ADF-600L	S7C7801360	DCO
Panasonic	Printer	KX-P10911	None	ACJ5Z6KX-P10911

**1.9 External I/O Cabling List and Details**

<b>Cable Description</b>	<b>Length (M)</b>	<b>Port/From</b>	<b>To</b>
Shielded Keyboard Cable	1.6	Keyboard /Host	Keyboard
Shielded Mouse Cable	1.8	Mouse/Host	Mouse
Shielded Video Cable	1.8	Video Card/Host	Monitor
Shielded Cable	1.8	SCCI Card/Host	ScanMaker SCSI Port1/EUT
Shielded Cable	2.0	Parallel /EUT	Panasonic Printer
Shielded Cable	0.25	ADF /EUT	ADF Device

## **2 - SYSTEM TEST CONFIGURATION**

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### **2.1 Justification**

The system was configured for testing in a typical fashion (as a normally used by a typical user).

The motherboard provided the following I/O ports and connectors: two (2) serial ports, one (1) parallel port, one (1) ATX keyboard port, one (1) floppy interface connector, and two (2) IDE interface connectors.

The EUT was tested in the native mode to represent worst case results during the final qualification test. The parallel port (LPT1), ATX keyboard port, and both serial ports (COM1 and COM2) were also tested.

### **2.2 EUT Exercise Software**

The EUT exercising program used during radiated and conducted testing was designed to exercise the various system components in a manner similar to a typical use. The test software, Scantest.exe, contained on the hard drive is started the Windows 95 terminal program under the Windows 95 operating system. Once loaded, the program sequentially exercises each system component.

The sequence used is as follows:

- 1) Activated the scanner.
- 2) The scanner moved from one end to other end to scan documents.
- 3) The host received data from scanner and stored in hard drive.

This process is continuous throughout all tests.

At the same time, a test software, emctest.exe, contained on the hard drive is started the Windows 95 terminal program under the Windows 95 operating system. Once loaded, the program sequentially exercises each system component.

The sequence used is as follows:

1. Send H pattern to the monitor
2. The H program sends commands to the PC System.
3. The modem receives Hs.

This process is continuous throughout all tests.

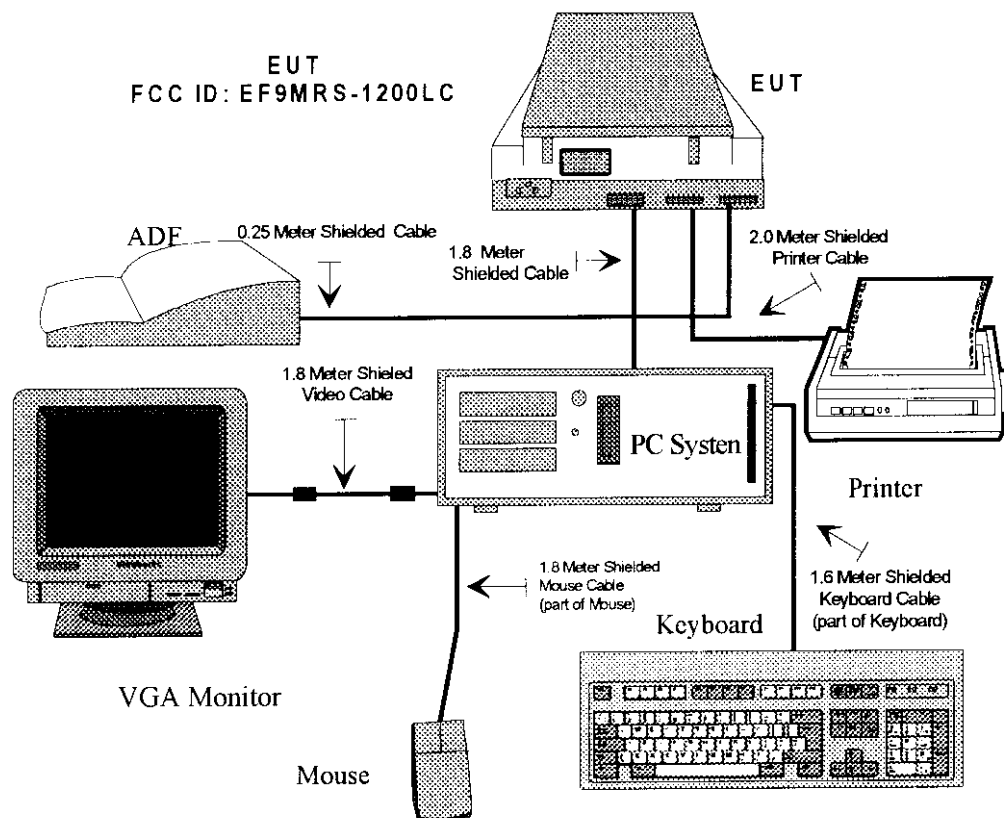
### **2.3 Special Accessories**

As shown in section 2.5, all interface cables used for compliance testing are shielded as normally supplied by INMAC and their respective support equipment manufacturers. The monitor featured shielded metal connectors.

### **2.4 Schematics / Block Diagram**

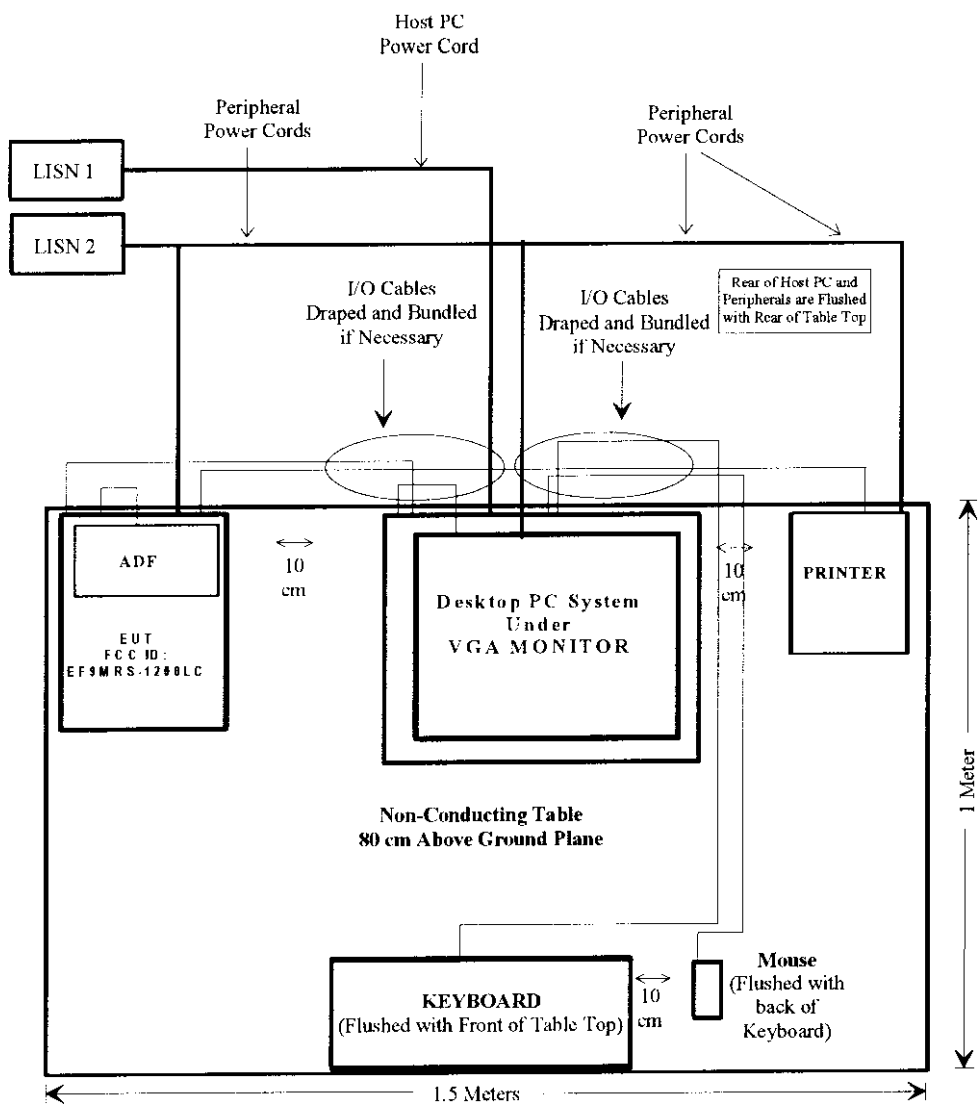
Appendix A contains a copy of the EUT's schematics diagram as reference.

## 2.5 Configuration of Test System





## 2.6 Test Setup Block Diagram



## 2.7 Equipment Modifications

No modification(s) were necessary for the EUT to comply with the applicable standards and limits.

### 3 - CONDUCTED EMISSIONS TEST DATA

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#### 3.1 Measurement Uncertainty

All measurements involve certain levels of uncertainties, especially in field of EMC. The factors contributing to uncertainties are spectrum analyzer, cable loss, and LISN.

Based on NIS 81, The Treatment of Uncertainty in EMC Measurements, the best estimate of the uncertainty of any conducted emissions measurement at BACL is  $\pm 2.4$  dB.

#### 3.2 EUT Setup

The measurement was performed at the **Open Area Test Site**, using the same setup per ANSI C63.4 - 1992 measurement procedure. The specification used was the FCC Class B limits.

The EUT was placed on the left side of the test table with the ADF (Automatic Document Feeder) on the top of the EUT. The VGA monitor was placed on the top of the Desktop PC system next to the EUT, the printer was placed next to the PC system on the right side of the test table. The rear of the PC system and peripherals were placed flushed with the rear/sides of the tabletop.

The keyboard was placed in front of the Desktop PC system, flushed with the front of the tabletop. The mouse was placed next to the keyboard and flushed with the back of the keyboard.

The spacing between the peripherals was 10 cm.

#### 3.3 Spectrum Analyzer Setup

The spectrum analyzer was set with the following configuration during the conduction test:

Start Frequency.....	450 kHz
Stop Frequency.....	30 MHz
Sweep Speed .....	Auto
IF Bandwidth.....	100 kHz
Video Bandwidth.....	100 kHz
Quasi-Peak Adapter Bandwidth .....	9 kHz
Quasi-Peak Adapter Mode .....	Normal

### 3.4 Test Procedure

During the conducted emission test, the power cord of the host system was connected to the auxiliary outlet of the first LISN. The VGA monitor and all other support equipment power cords were connected to the auxiliary power outlet of the second LISN.

Maximizing procedure was performed on the six (6) highest emissions to ensure EUT is compliant with all installation combination.

All data was recorded in the peak detection mode. Quasi-peak readings were only performed when an emission was found to be marginal (less than -4 dB $\mu$ V). Quasi-peak readings are distinguished with a "Qp".

The EUT was operating at normal (native) mode tested during the final qualification test to represent worst case results.

Additionally, the EUT was tested with the *EUT Inside Power Supply (110 V)*.

### 3.5 Summary of Test Results

According to the data in section 3.6, the EUT complied with the FCC Conducted margin for a Class B device and these test results is deemed as satisfactory evidence of compliance with ICES-003 of the Canadian Interference-Causing Equipment Regulations, with the *worst* margin reading of:

-7.0 dB $\mu$ V at 0.630 MHz in the **Neutral** mode, native operating mode with the *EUT Inside* power supply (110V).

### 3.6 Conducted Emissions Test Data

#### 3.6.1 Test Data with EUT Inside Power Supply, 110V, 0.45 - 30 MHz.

LINE CONDUCTED EMISSIONS				FCC CLASS B	
Frequency	Amplitude	Detector	Phase	Limit	Margin
MHz	DB $\mu$ V	Qp/Ave/Peak	Line/Neutral	dB $\mu$ V	dB
0.630	41.0	QP	Neutral	48	-7.0
0.750	39.9	QP	Line	48	-8.1
0.780	38.4	QP	Neutral	48	-9.6
9.490	38.3	QP	Neutral	48	-9.7
15.280	37.0	QP	Line	48	-11.0
14.840	28.0	QP	Line	48	-20.0

### 3.7 Plot of Conducted Emissions Test Data

Plot(s) of Conducted Emissions Test Data with *EUT Inside Power Supply* is presented in Appendix B of this report as reference.

## 4 - RADIATED EMISSION DATA

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### 4.1 Measurement Uncertainty

All measurements involve certain levels of uncertainties, especially in field of EMC. The factors contributing to uncertainties are spectrum analyzer, cable loss, antenna factor calibration, antenna directivity, antenna factor variation with height, antenna phase center variation, antenna factor frequency interpolation, measurement distance variation, site imperfections, mismatch (average), and system repeatability.

Based on NIS 81, The Treatment of Uncertainty in EMC Measurements, the best estimate of the uncertainty of a radiation emissions measurement at BACL is  $\pm 4.0$  dB.

### 4.2 EUT Setup

The radiated emission tests were performed in the open area *3 meter* test site, using the setup accordance with the ANSI C63.4 - 1992. The specification used was the FCC Part 15 Class B limits.

The EUT was placed on the left side of the test table with the ADF (Automatic Document Feeder) on the top of the EUT. The VGA monitor was placed on the top of the Desktop PC system next to the EUT, the printer was placed next to the PC system on the right side of the test table. The rear of the PC system and peripherals were placed flushed with the rear/sides of the tabletop.

The keyboard was placed in front of the Desktop PC system, flushed with the front of the tabletop. The mouse was placed next to the keyboard and flushed with the back of the keyboard.

The spacing between the peripherals was 10 cm.

### 4.3 Spectrum Analyzer Setup

According to FCC Rules, 47 CFR 15.33, since the internal operating clock speed is below 108 MHz, the system was tested to 1000 MHz.

During the radiated emission test, the spectrum analyzer was set with the following configurations:

Start Frequency .....	30 MHz
Stop Frequency .....	1000 MHz
Sweep Speed .....	Auto
IF Bandwidth .....	100 kHz
Video Bandwidth .....	1 MHz
Quasi-Peak Adapter Bandwidth .....	120 kHz
Quasi-Peak Adapter Mode .....	Normal
Resolution Bandwidth .....	1MHz

#### 4.4 Test Procedure

For the radiated emissions test, the power cord of the EUT, VGA monitor and all support equipment were connected to the AC floor outlet since the power supply used inside the EUT did not provide an accessory power outlet.

Maximizing procedure was performed on the highest emissions to ensure EUT is compliant with all installation combinations.

All data was recorded in the peak detection mode. Quasi-peak readings was performed only when an emission was found to be marginal (less than -4 dBμV), and are distinguished with a "Qp" in the data table.

The EUT was operating at normal (native) mode tested during the final qualification test to represent worst case results.

#### 4.5 Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

$$\text{Corr. Ampl.} = \text{Indicated Reading} + \text{Antenna Factor} + \text{Cable Factor} - \text{Amplifier Gain}$$

The "**Margin**" column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of -7dBμV means the emission is 7dBμV below the maximum limit for FCC Class B. The equation for margin calculation is as follows:

$$\text{Margin} = \text{Corr. Ampl.} - \text{FCC Class B Limit}$$

#### 4.6 Summary of Test Results

According to the data in section 4.7, the EUT complied with the FCC Class B standards and these test results are deemed satisfactory evidence of compliance with ICES-003 of the Canadian Interference-Causing Equipment Regulations, and had the worst margin of:

**-3.6 dBμV at 430.18 MHz in the Horizontal polarization with Pentium II 233 CPU, 30 to 1000MHz.**

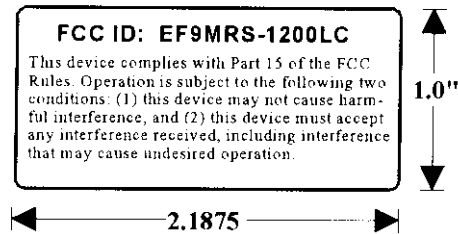
## 4.7 Radiated Emissions Test Data

### 4.7.1 Final Test Data for Normal (Native) Mode with Pentium II 233 CPU, 30-1000 MHz –3 meters

INDICATED		TABLE	ANTENNA		CORRECTION FACTOR			CORRECTED AMPLITUDE	FCC CLASS B	
Frequency	Ampl.	Angle	Height	Polar	Antenna	Cable	Amp.	Corr. Ampl.	Limit	Margin
MHz	dB $\mu$ V/m	Degree	Meter	H/V	dB $\mu$ V/m	dB	dB	dB $\mu$ V/m	dB $\mu$ V/m	dB
430.18	42.7	45	2.3	H	17.5	2.9	20.7	42.4	46.0	-3.6
190.07	44.9	280	2.2	H	14.4	2.7	22.5	39.5	43.5	-4.0
43.35	43.0	0	1.6	H	12.1	0.7	19.9	35.9	40.0	-4.1
390.15	42.5	90	1.1	V	16.5	2.8	20.2	41.6	46.0	-4.4
387.47	40.2	270	1.8	H	16.2	3.9	19.8	40.5	46.0	-5.5
425.24	39.1	280	1.1	V	17.2	3.0	19.7	39.6	46.0	-6.4
359.12	41.0	180	1.7	H	15.5	4.3	21.8	39.0	46.0	-7.0
337.49	42.5	225	1.2	H	15.0	2.6	21.9	38.2	46.0	-7.8
189.03	39.8	0	1.7	H	13.8	3.9	22.1	35.4	43.5	-8.1
43.78	38.9	0	1.2	H	12.1	0.7	19.9	31.8	40.0	-8.2
190.07	40.6	270	1.1	V	14.4	2.7	22.5	35.2	43.5	-8.3
364.49	38.0	60	1.1	V	15.5	5.2	22.6	36.1	46.0	-9.9
243.01	39.8	90	1.6	H	12.6	2.3	22.5	32.2	46.0	-13.8
121.51	33.5	180	1.1	V	12.1	2.2	19.5	28.3	43.5	-15.2
243.44	38.1	225	1.1	V	12.6	2.3	22.5	30.5	46.0	-15.5

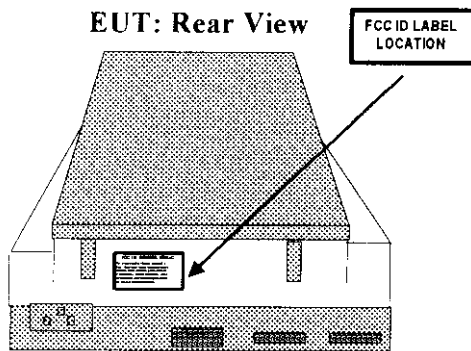
## 5- FCC PRODUCT LABELING AND WARNING STATEMENT

### 5.1 FCC ID Label



Specifications: Text is black in color and is left justified. Labels are printed in indelible ink on permanent adhesive backing and shall be affixed at a conspicuous location on the EUT.

### 5.2 Proposed Label Location on EUT



### 5.3 FCC Warning Statement

The FCC Warning Statement is provided with the product manual. A sample of the statement is presented in Appendix C of this report as reference.



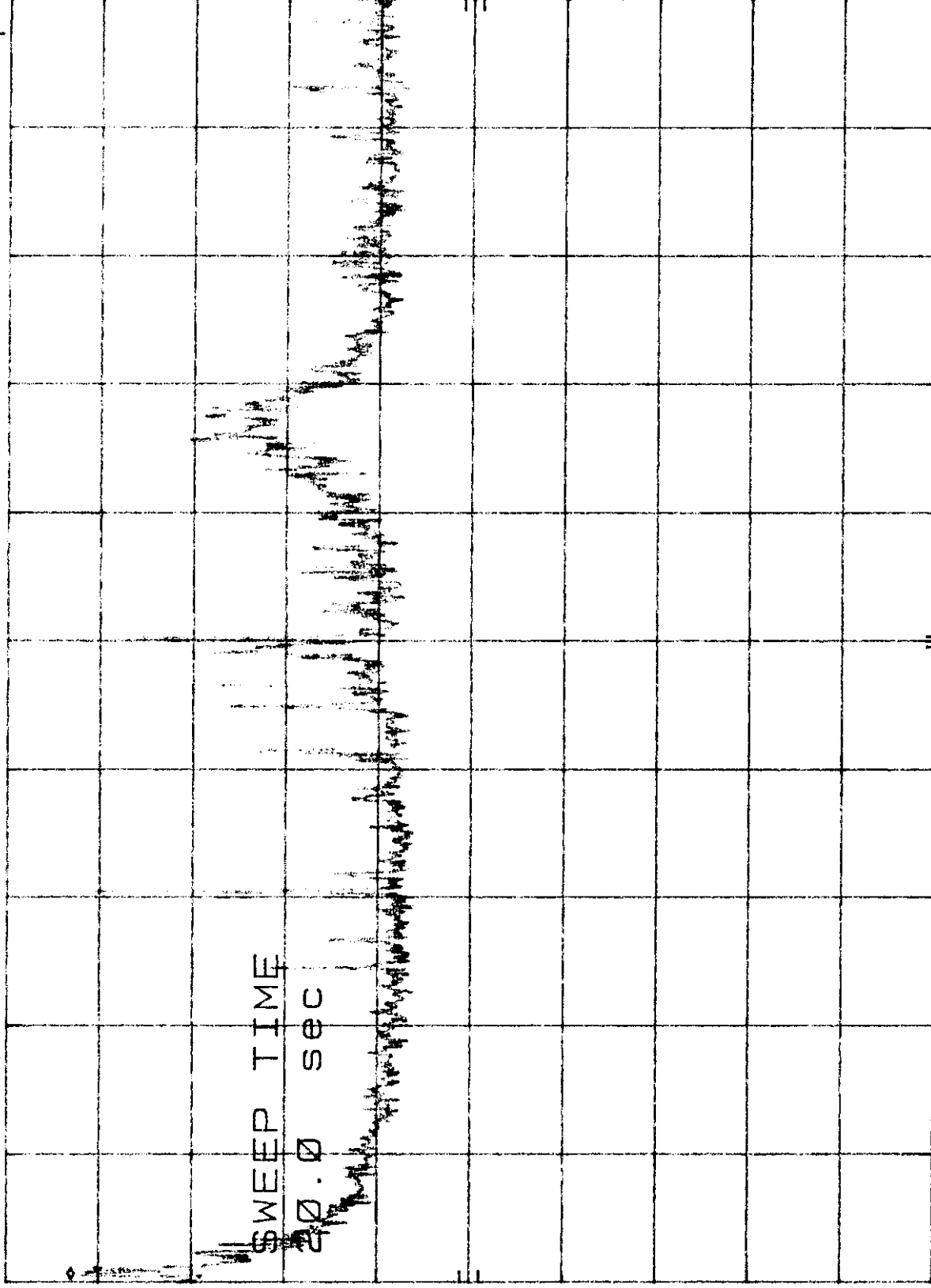
## **Appendix B – PLOT(S) OF CONDUCTED EMISSION TEST DATA**

MICROTEK MRS-1200LC  
REF 48.0 dBμV ATTN 0 dB

MKR 630 KHZ  
41.00 dBμV

hp

10 dB/



START 450 KHZ

RES BW 10 KHZ

VBW 10 KHZ

STOP 30.0 MHz

SWP 20.0 sec